

<b>Form PTO 1449</b> Rev. 7-80 <b>U.S. Department of Commerce</b> Patent and Trademark Office <b>LIST OF PRIOR ART CITED BY APPLICANT</b> (Use Several Sheets If Necessary)	<div style="text-align: right;">Sheet 1 of 1</div> <table border="1" style="width: 100%; border-collapse: collapse;"> <tr> <td style="width: 50%;">Atty. Docket No. CH-8006/LeA 36,004</td> <td style="width: 50%;">Serial No. To Be Assigned</td> </tr> <tr> <td colspan="2">Applicant Gueltekin Erdem et al</td> </tr> <tr> <td>Filing Date Herewith</td> <td>Group</td> </tr> </table>	Atty. Docket No. CH-8006/LeA 36,004	Serial No. To Be Assigned	Applicant Gueltekin Erdem et al		Filing Date Herewith	Group
Atty. Docket No. CH-8006/LeA 36,004	Serial No. To Be Assigned						
Applicant Gueltekin Erdem et al							
Filing Date Herewith	Group						

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	3,170,961	02/23/65	Britton et al	260	650	
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						

**FOREIGN PATENT DOCUMENTS**

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							Yes	No*
	AL	53 44528	04/21/78	Japan (Abstract Attached)				X
	AM	54 160322	12/19/79	Japan (Abstract Attached)				X
	AN	58 174333	10/13/83	Japan (Abstract Attached)				X
	AO	11 158093	06/15/99	Japan (Abstract Attached)				X
	AP							

**OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)**

	AR	
	AS	
	AT	

EXAMINER	DATE CONSIDERED
EXAMINER Initial if references considered, whether or not citation is in conformance with MPEP 609: Draw line through if not in conformance and not considered. Include copy of this form with next communication to applicant.	

\* Neither English Language Equivalent nor an English Language Translation is available.